

INCH-POUND

MIL-STD-1276E

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SUPERSEDING

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MILITARY STANDARD

LEADS FOR ELECTRONIC COMPONENT PARTS



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DISTRIBUTION STATEMENT A.

FSC 5999

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MIL-STD-1276E

DEPARTMENT OF DEFENSE
Washington, DC 20360

Leads for Electronic Component: Parts

1. This standard is approved for use by all Departments and Agencies of the Department of Defense.
2. Beneficial comments (recommendations, additions, deletions) and any pertinent data which may be of use in improving this document should be addressed to: U. S. Army Research Laboratory Command, Electronics and Power Sources Directorate/ARL, Reliability and Manufacturing Science Division, ATTN: AMSRL-EP-ED, Fort Monmouth, NJ 07703-5601 by using the Standardization Document Improvement Proposal (DD Form 1426) appearing at the end of this document or by letter.

CONTENTS

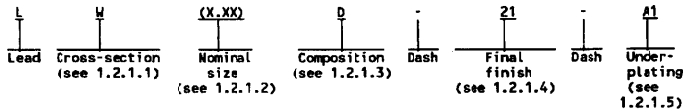
<u>PARAGRAPH</u>	<u>PAGE</u>
1. SCOPE - - - - -	1
1.1 Purpose - - - - -	1
1.2 Classification - - - - -	1
1.2.1 Type designation - - - - -	1
1.2.1.1 Cross section - - - - -	1
1.2.1.2 Nominal size - - - - -	1
1.2.1.3 Composition - - - - -	1
1.2.1.4 Final finish - - - - -	1
1.2.1.5 Underplating - - - - -	1
2. APPLICABLE DOCUMENTS - - - - -	3
2.1 Government documents - - - - -	3
2.1.1 Specifications, standards, and handbooks - - - - -	3
2.2 Non-Government publications - - - - -	3
2.3 Order of precedence - - - - -	4
3. DEFINITIONS (Not applicable) - - - - -	5
4. GENERAL REQUIREMENTS - - - - -	6
4.1 Preferred methods of assembly - - - - -	6
4.2 Solderability - - - - -	7
4.3 Thickness - - - - -	7
4.4 Adhesion - - - - -	7
4.5 Porosity - - - - -	7
4.6 Workmanship in finishes - - - - -	7
5. DETAILED REQUIREMENTS - - - - -	8
5.1 Composition - - - - -	8
5.2 Final finish - - - - -	8
5.2.1 Underplating thickness - - - - -	9
5.2.1.1 Gold plating - - - - -	9
5.2.1.2 Compositions F, G, and K - - - - -	9
5.2.1.3 Hot solder dip - - - - -	9
5.2.1.4 Compositions A, B, J, and X - - - - -	9
6. NOTES - - - - -	10
6.1 Precaution - - - - -	10
6.2 Removal of gold plating before soldering - - - - -	10
6.3 Passive nickel - - - - -	10
6.4 Cross reference - - - - -	10
6.5 Cleanliness - - - - -	11
6.6 Supersession data - - - - -	11
6.7 Subject term (key word) listing - - - - -	12
6.8 Changes from previous issue - - - - -	12
 <u>TABLES</u>	
Table I Noninal size - - - - -	2
Table II Preferred methods of assembly - - - - -	6
Table III Cross reference of lead types - - - - -	10
Table IV Supersession data for final finishes - - - - -	11

1. SCOPE

1.1 Purpose. This standard establishes the method of identifying, specifying, and limiting to a minimum the combinations of basic materials, the thickness and composition of the plating used therewith, and the sizes of wire and (flat wire (ribbon) leads on electronic and electrical parts when they are to be soldered or welded during assembly in equipment.

1.2 Classification.

1.2.1 Type designation. The type designation shall be in the following format:



1.2.1.1 Cross section. The lead cross section shall be identified by a single letter symbol as follows:

- R - Rectangular.
- S - Square.
- W - Wire (round or circular).
- X - Other (as specified).

1.2.1.2 Nominal size. The lead size shall be identified by the nominal diameter or nominal diagonal in millimeters (within parentheses) or inches (without parentheses). See table 1 for a list of suggested nominal sizes.

1.2.1.3 Composition. The lead composition shall be identified by a single letter symbol as specified in 5.1.

1.2.1.4 Final finish. The final finish for leads shall be identified by a two-number code as specified in 5.2.

1.2.1.5 Underplating. The underplating type and thickness shall be identified by a one or two digit alpha-numeric code as specified in 5.2.1.

TABLE I. Nominal size (for information only).

Wire size AWG (B and S)	Diameter in inches	Diameter in millimeters
1	0.289	7.34
2	0.257	6.53
3	0.229	5.82
4	0.204	5.18
5	0.181	4.60
6	0.152	4.11
7	0.144	3.65
8	0.128	3.25
9	0.114	2.90
10	0.101	2.57
11	0.090	2.29
12	0.080	2.03
13	0.072	1.83
14	0.064	1.63
15	0.057	1.45
16	0.050	1.27
17	0.045	1.14
18	0.040	1.02
19	0.035	0.89
20	0.032	0.81
21	0.028	0.71
22	0.025	0.64
23	0.022	0.56
24	0.020	0.51
25	0.017	0.43
26	0.015	0.38
27	0.014	0.36
28	0.012	0.30
29	0.011	0.28
30	0.010	0.25
31	0.008	0.20
32	0.008	0.20
33	0.007	0.18
34	0.006	0.15
35	0.005	0.13
36	0.005	0.13
37	0.004	0.10
38	0.004	0.10
39	0.003	0.08
40	0.003	0.08

2. APPLICABLE DOCUMENTS

2.1 Government documents.

2.1.1 Specifications, standards, and handbooks. The following specifications, standards, and handbooks form a part of this document to the extent specified herein. Unless otherwise specified, the issues of these documents are those listed in the issue of the Department of Defense Index of Specifications and Standards (DODISS) and supplement thereto, cited in the solicitation.

SPECIFICATIONS

FEDERAL

- QQ-N-290 - Nickel Plating (Electrodeposited).
- QQ-S-365 - Silver Plating, Electrodeposited; General Requirements for.
- QQ-S-571 - Solder, Tin Alloy; Tin-Lead Alloy; and Lead Alloy.

MILITARY

- MIL-T-10727 - Tin Plating: Electrodeposited or Hot-Dipped, for Ferrous and Nonferrous Metals.
- MIL-C-14550 - Copper, Plating Electrodeposited.
- MIL-C-26074 - Coatings, Electroless Nickel, Requirements for.
- MIL-G-45204 - Gold Plating, Electrodeposited.
- MIL-N-46025 - Nickel Bar, Flat Wire (Ribbon) and Strip (for Electronic Use).
- MIL-N-46026 - Nickel Rod and Wire (Round) (for Electronic Use).
- MIL-P-81728 - Plating, Tin-Lead (Electrodeposited).

STANDARDS

MILITARY

- MIL-STD-202 - Test Methods for Electronic and Electrical Component Parts.
- MIL-STD-750 - Test Methods for Semiconductor Devices.
- MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Unless otherwise indicated, copies of the federal and military specifications, standards, and handbooks are available from the Standardization Documents Order Desk, Building 4D, 700 Robbins Avenue, Philadelphia, PA 19111-5094.)

2.2 Non-Government publications. The following documents form a part of this document to the extent specified herein. Unless otherwise specified, the issues of the documents which are DOD adopted are those listed in the issue of the DODISS specified in the solicitation. Unless otherwise specified, the issues of documents not listed in the DODISS are the issues of the documents cited in the solicitation.

AMERICAN SOCIETY FOR TESTING AND MATERIALS (ASTM)

- ASTM B5 - Standard Specification for Electrolytic Tough-Pitch Copper Refinery Shapes.
- ASTM B122 - Standard Specification for Copper-Nickel-Tin Alloy, Copper-Nickel-Zinc Alloy (Nickel Silver), and Copper-Nickel Alloy Plate, Sheet, Strip and Rolled Bar.
- ASTM B170 - Standard Specification for Oxygen-Free Electrolytic Copper-Refinery Shapes.
- ASTM B322 - Cleaning Metals Prior to Electroplating, Practice for.
- ASTM B343 - Standard Practice for Preparation of Nickel for Electroplating with Nickel.
- ASTM B465 - Copper-Iron Alloy Plate, Sheet, Strip, and Rolled Bar.
- ASTM B487 - Standard Practice for Measurement of Metal and Oxide Coating Thickness by Microscopical Examination of a Cross-section.
- ASTM B545 - Standard Specification for Electrodeposited Coatings of Tin.
- ASTM B571 - Standard Test Methods for Adhesion of Metallic Coating.
- ASTM B592 - Standard Test Methods for Copper-Zinc-Aluminum-Cobalt or Nickel-Alloy Plate, Sheet, Strip, and Rolled Bar, Specification for.
- ASTM B735 - Standard Test Method for Porosity in Gold Coatings on Metal Substrates by Nitric Acid Vapor.
- ASTM B741 - Standard Test Method for Porosity in Gold Coatings on Metal Substrates by Paper Electrography.
- ASTM F15 - Standard Specification for Iron-Nickel-Cobalt Sealing Alloy.
- ASTM F29 - Standard Specification for Dumet Wire for Glass-to-Metal Seal Applications.
- ASTM F30 - Standard Specification for Iron-Nickel Sealing Alloy.

(Application for copies should be addressed to the American Society for Testing and Materials, 1916 Race Street, Philadelphia, PA 19103.)

MIL-STD-1276E

(Non-Government standards and other publications are normally available from the organizations that prepare or distribute the documents. These documents also may be available in or through libraries or other informational services.)

2.3 Order of precedence. In the event of a conflict between the text of this document and the references cited herein, the text of this document shall take precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

3. DEFINITIONS

3.1 Definitions. This section is not applicable to this standard.

4. GENERAL REQUIREMENTS

4.1 Preferred methods of assembly. The preferred methods of assembly shall be in accordance with table 11.

TABLE 11. Preferred methods of assembly.

Composition (see 5.1)	Underplating (see 5.2.1)	Final finish (see 5.2)											
		01	21	22	32	34	41	43	51	52	61	71	72
A	A	---	S,W	S,W	S	S	S	S	S	S	W	S	S
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	---	---	---	---	---	---	---	---	---
B	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	A	---	---	---	"	"	"	"	"	"	"	"	"
"	B	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	W	---	"	"	"	"	"	"	"	"	"
D	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
E	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
F	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
G	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
H	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
J	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
K	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
L	A	---	---	---	"	"	"	"	"	"	"	"	"
"	B	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
M	A	---	---	---	"	"	"	"	"	"	"	"	"
"	B	---	---	---	"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"

TABLE II. Preferred methods of assembly - Continued.

Composition	Underplating	Final finish											
		01	21	22	32	34	41	43	51	52	61	71	72
N					S	S	S	S	S	S	W	S	S
"					"	"	"	"	"	"	"	"	"
"	C	---	---	---	"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	W	---	---	"	"	"	"	"	"	"	"	"
W	A	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"	B	---	S,W	S,W	"	"	"	"	"	"	"	"	"
"					"	"	"	"	"	"	"	"	"
"	P	---	---	---	"	"	"	"	"	"	"	"	"
"	N	---	---	---	"	"	"	"	"	"	"	"	"
X	As specified in the acquisition document												

S = Solder

W = Weld

4.2 Solderability. When specified in the acquisition document, leads shall meet the following solderability requirements:

- a. Discrete semiconductor devices: Test method 2026 of MIL-STD-750.
- b. Microelectronics: Test method 2002 or test method 2003 of MIL-STD-883.
- c. Other electronic and electrical component parts: Test method 208 of MIL-STD-202.

4.3 Thickness. When specified in the acquisition document, the thickness of the final finish and underplating shall be determined in accordance with ASTM B487 or ASTM B567.

4.4 Adhesion. When specified in the acquisition document, the adhesion of the final finish and underplating shall be determined in accordance with ASTM B571 or method 2025 of MIL-STD-883.

4.5 Porosity. When specified in the acquisition document, there shall be no evidence of porosity for final finishes 21, 22, and 61 when tested in accordance with ASTM B735 or ASTM B741.

4.6 Workmanship in finishes. All plating of primary finishes or underplating shall be deposited in such a way that the plating is applied to a clean, nonoxidized metal surface that is free from defects that will be detrimental to the utility, form, fit, function, or protective value of the finish. Where surface cleaning, deoxidation, activation, undercoating, etc., are used, the material or device so treated must proceed immediately to the primary finish process in order to maintain the ability to overplate effectively.

5. DETAILED REQUIREMENTS

5.1 Composition. The specified lead composition (see 1.2.1.3) shall conform to the requirements of the applicable documents as follows:

- A - Copper-iron-phosphorus-zinc alloy (194 alloy): ASTM B465 (see 5.2.1.4).
- B - Copper-iron-phosphorus-cobalt-tin alloy (195 alloy), 97 percent Cu, 1.5 percent Fe, 0.1 percent P, 0.8 percent Co, and 0.6 percent Sn (see 5.2.1.4).
- C - Copper (oxygen free): ASTM B170, grade 2.
- D - Copper-clad nickel-iron alloy (Dumet): ASTM F29.
- E - Copper-nickel-tin alloy (725 alloy), 88.2 percent Cu, 9.5 percent Ni, and 2.3 percent Sn: ASTM B122.
- F - Iron-nickel alloy (52 alloy): ASTM F30 (see 5.2.1.2).
- G - Iron-nickel alloy (62 alloy): ASTM F30 (see 5.2.1.2).
- H - Copper-aluminum-silicon-cobalt alloy (638 alloy), 95.0 percent Cu, 2.8 percent Al, 1.8 percent Si, and 0.4 percent Co.
- J - Copper-zinc-aluminum-cobalt alloy (688 alloy): ASTM B592 (see 5.2.1.4).
- K - Iron-nickel-cobalt alloy: ASTM F15 (see 5.2.1.2).
- L - Copper, Electrolytic tough - pitch: ASTM B5.
- M - Steel, nickel clad, 8 percent nickel clad by weight.
- N - Nickel: MIL-N-46025 (for ribbon leads) or MIL-N-46026 (for round-wire leads).
- W - Steel, copper-clad: ASTM B452 (except that the percent of conductivity shall be a minimum of 16 percent).
- X - Other composition as specified in the acquisition document (see 5.2.1.4).

5.2 Final finish. The final finish for leads (see 1.2.1.4) shall conform to the following as applicable:

- 01 - No finish. Lead is supplied with no external finish.
- 21 - Gold plating, electrodeposited, in accordance with MIL-G-45204, type I. The thickness of the gold plating shall be 100 to 300 microinches. When specified, under-plating shall be in accordance with 5.2.1.1.
- 22 - Gold plating, electrodeposited, in accordance with MIL-G-45204, type I. The thickness of the gold plating shall be 50 to 100 microinches. When specified, under-plating shall be in accordance with 5.2.1.1.
- 32 - Tin-lead plating, electrodeposited, in accordance with MIL-P-81728. Composition shall be 50 to 70 percent tin (remainder lead). The thickness shall be 300 to 900 microinches (22.9 μm).
- 34 - Fused (reflowed) tin-lead plating, electrodeposited, in accordance with MIL-P-81728. Composition shall be 50 to 70 percent tin (remainder lead). The tin-lead thickness after fusing (or reflow), shall not be less than 100 microinches (2.54 μm) at any single point. The average thickness of all points measured shall be 300 (7.62 μm) to 500 microinches (12.7 μm).
- 41 - Acid-tin-lead plating, electrodeposited, in accordance with MIL-T-10727. Thickness shall be 300 (7.62 μm) to 500 microinches (12.7 μm). Minimum lead content shall be 3 percent.
- 43 - Matte-tin-lead plating, electrodeposited, in accordance with MIL-T-10727, type I. The thickness shall be 300 (7.62 μm) to 500 microinches (12.7 μm). The matte-tin plating shall contain no more than 0.05 percent by weight codeposited organic material measured as elemental carbon. Minimum lead content shall be 3 percent.
- 45 - Acid-tin-lead plating, electrodeposited, in accordance with MIL-T-10727. Thickness shall be 100 (2.54 μm) to 300 microinches (7.62 μm). Minimum lead content shall be 3 percent.
- 46 - Matte-tin-lead plating (low organic content), electrodeposited, in accordance with MIL-T-10727, type I. The thickness shall be 100 (2.54 μm) to 300 microinches (7.62 μm). The matte-tin plating shall contain no more than 0.05 percent by weight codeposited organic material measured as elemental carbon. Minimum lead content shall be 3 percent.
- 51 - Hot solder dip. The composition shall be Sn 60, Sn 63, or Sn 62 per QQ-S-571. The coating shall have a minimum thickness of 200 microinches as measured at the crest. Hot solder dip finish may be used over final finish types 21, 22, 32, 34, 41, 43, 45, 46, 61, 71, and 72. When specified (see 1.2.1.5), electroless nickel underplating may be used in accordance with 5.2.1.3.
- 52 - Hot solder dip. The composition shall be Sn 60, Sn 63, or Sn 62 per QQ-S-571. Thickness shall be 60-200 microinches as measured at the crest. Hot solder dip finish may be used over final finish types 21, 22, 32, 34, 41, 43, 45, 46, 61, 71, and 72. When specified (see 1.2.1.5), electroless nickel underplating may be used in accordance with 5.2.1.3.
- 61 - Nickel plating, electrodeposited, in accordance with QQ-N-290. Thickness shall be 50 (1.27 μm) to 150 microinches (3.81 μm). The nickel plating shall be nonbrightened and low stress.
- 71 - Silver plating, electrodeposited, in accordance with QQ-S-365, type II, grade B. Thickness shall be 150 (3.81 μm) to 350 microinches (8.89 μm).
- 72 - Silver plating, electrodeposited, matte, nonbrightened, in accordance with QQ-S-365, type I. Thickness shall be 150 (3.81 μm) to 350 microinches (8.89 μm).

5.2.1 Underplating. The underplating (see 1.2.1.5) shall conform to the following requirements:

- A - Nickel, electrolytic.
 - 1 - 60 (1.52 μm) to 150 microinches (3.81 μm) thick.
 - 2 - 100 (2.54 μm) to 300 microinches (7.62 μm) thick.
 - 3 - 20 (0.50 μm) to 60 microinches (1.52 μm) thick.
- B - Nickel, electroless (not to be used on flexible or semirigid leads).
 - 1 - 100 (2.54 μm) to 200 microinches (5.08 μm) thick.
 - 2 - 50 (1.27 μm) to 120 microinches (3.04 μm) thick.
- C - Copper, electrodeposited.
 - 1 - 60 (1.52 μm) to 150 microinches (3.81 μm) thick.
 - 2 - 150 (3.81 μm) to 300 microinches (7.62 μm) thick.
 - 3 - 20 (0.50 μm) to 60 microinches (1.52 μm) thick.
- P - Palladium-nickel alloy.
 - 1 - 50 (1.27 μm) to 100 microinches (2.54 μm) thick.
- N - no underplating.

5.2.1.1 Gold plating. A copper plus electrodeposited nickel or electrodeposited nickel underplating is required on all leads with gold plating as the final finish in accordance with MIL-C-14550.

5.2.1.2 Compositions F, G, and K. All leads with composition F, G, or K (see 5.1) shall have an underplating prior to final finish.

5.2.1.3 Hot solder dip. When specified for use under hot solder dip lead finish (see 5.2), the electroless nickel underplating shall be in accordance with MIL-C-26074. The thickness shall be as designated in 5.2.1.B.

5.2.1.4 Compositions A, B, J, and X. All leads with compositions A, B, J, or X (see 5.1) shall have a copper or nickel underplate of 100 microinches (2.54 μm) minimum.

MIL-STD-1276E

6. NOTES

(This section contains information of a general or explanatory nature that may be helpful, but is not mandatory.)

6.1 Precaution. Substitution of any type of lead for the existing leads on electronic component parts should not be made in a parts specification without first determining the effect of this substitution on the performance and solderability characteristics of the component part.

6.2 Removal of gold plating before soldering. Prior to equipment assembly, gold plated leads shall have the gold removed before soldering by single or double dipping into a flowing or nonflowing hot solder of sufficient volume to assure complete gold removal.

6.3 Passive nickel. If there is a delay after the application of nickel strike, where the nickel surface may have become passive, the nickel shall be reactivated followed by gold plating. Reactivation of the nickel surface should be in accordance with the appropriate section of the latest ASTM standards. (Reference: ASTM B322, Cleaning Metals Prior to Electroplating; and ASTM B343, Preparation of Nickel for Electroplating with Nickel.)

6.4 Cross reference. A cross reference of discontinued and superseding lead types appears in table III. Where MIL-STD-1276B designations are specified, the cross referenced MIL-STD-1276C designations may be used.

TABLE III. Cross reference of lead types.

Superseding type			Discontinued type
MIL-STD-1276C			MIL-STD-1276B
Composition	Final finish	Underplating	
C	3	---	C (tin plated)
C	4	---	C (tin-lead plated)
D	2a	A1	D
F	2a	A1	F
K	2a	A1	K
N	1	---	N-1
N	2a	---	N-2
N	3	---	N-3 (tin plated)
N	4	---	N-3 (tin-lead plated)

MIL-STD-1276E

TABLE III. Cross-reference of lead types - Continued.

MIL-STD-1276D		MIL-STD-1276C	
Composition		Composition	
A		Not available	
B		Not available	
C		D	
D		D	
E		Not available	
F		F	
G		G	
H		Not available	
J		Not available	
K		K	
L		C,	
M		Not available	
N		N	
W		W	
X		X	
Underplating (same as revision C with the addition of C and P)			
Final finish		Final finish	
01		1	
21		2a	
22		2b	
31		3	
32		4	
33		Not available	
34		Not available	
51		5a	
52		5b	
61		6	
71		7	
72		Not available	

6.5 Cleanliness. The last step in any component manufacturing process should be cleaning to remove residues such as fluxes.

6.6 Supersession data. Final finishes 31, 33, 35, and 36 are deleted, effective with revision E of this standard. These pure tin finishes may cause "fir whisker" growth leading to shorts and intermittents, especially in low power (5 mA and below) applications. For additional information on this matter, refer to ASTM B545 (Standard Specification for Electrodeposited Coating of Tin). Replacement finish codes are 41, 43, 45, and 46 respectively, as described in 1.2.1.4, 5.2, and table IV.

TABLE IV. Supersession data for final finishes.

Superseded (old) finish code (MIL-STD-1276D)	Superseding (new) finish code (MIL-STD-1276E)
31	41
33	43
35	45
36	46

6.7 Subject term (key word) listing.

Final finish
Plating
Terminals
Underplating

6.8 Changes from previous issue. Marginal notations are not used in this revision to identify changes with respect to the previous issue due to the extensiveness of the changes.

CONCLUDING MATERIAL

Custodians:

Army - ER
Navy - EC
Air Force - 85

Review activities:

Navy - AS, SI
Air Force - 17, 99
DLA - ES

User activities:

Navy - CG, MC

Preparing activity:
Army - ER

Agent:
DLA - ES

(Project 5999-0305)